First-Principle Electronic Properties of Monoclinic (Al_xIn_yGa_{1-x-y})₂O₃ Alloys

Xiaoli Liu[†], and Chee-Keong Tan[‡]

Department of Electrical and Computer Engineering, Clarkson University, Potsdam, NY 13699 USA [†]Email : liux8@Clarkson.Edu, [‡]Email : ctan@Clarkson.Edu

Abstract-First-Principle DFT calculations are carried out to investigate the electronic properties of β -(Al_xIn_yGa_{1-x-y})₂O₃ alloys with x ranging from 0~12.5% and y ranging from 0~ 18.75%. The electronic properties of monoclinic gallium oxide alloy with added aluminium and indium atoms are explored. The incorporation of both aluminium and indium results in the reduction of energy bandgap of β -(Al_xIn_yGa_{1-x-y})₂O₃ alloys. Additionally, indium of higher content than aluminium in the quaternary alloy promotes the indirect bandgap transferring to direct bandgap. This work provides new findings on the flexible band property modification of monoclinic gallium oxide-based material and indicates their potential in deep ultraviolet photodetector.

As a transparent semiconductor material with ultrawide bandgap of 4.6~4.9 eV [1], monoclinic gallium oxide (β -Ga₂O₃) is drawing humungous interests in various technological applications such as high-power field effect transistors, ultraviolet (UV) photodetectors and advanced micro/nanoelectromechanical systems. β -Ga₂O₃ material possesses excellent properties such as large critical breakdown field voltage and high electrical conductivity [2]. However, the application of β -Ga₂O₃ materials is still in the early stage due to the limitation including the p-type doping difficulty and low thermal conductivity.

Considering the requirement of material design flexibility for device applications, the materials from the same class are often implemented in the purpose of forming heterostructures for carrier confinement to enable optoelectronics with specific spectrum region for various technological applications including transistors, light emitting didoes, and photodetectors. Recent studies suggest emerging interests in applying β-Ga₂O₃-based compound alloys for various device technologies. Specifically, it is considered to incorporate aluminium (Al) or indium (In) to design ternary alloys, in a relatively similar fashion to the III-Nitride-based materials in the form of InGaN and AlGaN alloys [3]. Extensive research work on III-oxide binary alloys (Al2O3, Ga2O3 and In2O3) has been reported [4-9], but the understanding on the properties of β -Ga₂O₃-based ternary materials is still limited by far [5] comparing to that of other wide-established materials such as GaN and GaAs. More importantly, there has been no literature on the β -Ga₂O₃-based quaternary material. Thus, investigating the optoelectronic properties of the β -Ga₂O₃-based quaternary materials is critical to gauge their potential use in device applications.

In this work, the electronic band structures of β -(Al_xIn_yGa₁. _{x-y})₂O₃ alloys with Al-content (x) up to 12.5% and In-content (y) up to 18.75% are investigated using Density function



Fig. 1 supercell structure -Ga₂O₃ crystal.

theory (DFT) calculations. The effect of aluminium and indium atoms on the electronic properties of β -Ga₂O₃ quaternary alloys are then analyzed.

A. Simulation method

Fig. 1. illustrates an appropriate crystal model constructed for the band structure calculations using the supercell approach implemented in atomistic simulation package MedeA-VASP software [10,11]. The β -Ga₂O₃ crystal structure with 1×2×2 supercell consists 32 gallium atoms and 48 oxygen atoms in total. In the 80-atom supercell, one Ga atom is replaced by one aluminium or indium atom corresponds to a dilute concentration of 3.125%. Note that all the substituted gallium atoms are located at the octahedral sites of the β -Ga₂O₃ crystal structure, since the formation energy required to substitute Ga atom at tetrahedral site is higher compared to octahedral site [7]. Similar approach was implemented in creating β-(Al_xIn_yGa_{1-x})₂O₃ alloys with Al/Incontent up to 12.5%, in which the supercell size is kept unchanged. It is important to point out that the β -(Al_xIn_yGa_{1-x}- $_{\rm y}$)₂O₃ alloys with higher content are not considered in this study, due to the known phase separation issue in the β -Ga₂O₃ alloys [5]. First-Principle DFT calculations are then carried out using GGA-PBE exchange correlation functional for β - $(Al_x In_y Ga_{1-x-y})_2 O_3$ alloys.

B. Results and discussions

Fig. 2. presents the band structure of β -(Al_xIn_yGa_{1-x-y})₂O₃ alloys with x and y equal to 6.25%. The scissor operation has been applied to correct the error resulted from the GGA exchange correlation functional in the calculations [12]. According to the band structures of -(Al_xIn_yGa_{1-x-y})₂O₃ alloys

with different Al/In-contents obtained through DFT clculations, the alloys exhibit indirect band gaps.



Fig. 2 First principle calculated band structure of -(Al_xIn_yGa_{1.xy})₂O₃ alloy with x and y equal to 6.25%.

The conduction band minimum of the alloys is always located at the point in the Brillouin Zone, while the valance band maximum location is off the point. Further analysis revealed that when the content of indium is equal or higher than that of aluminium, the valance band maximum tends to move from Γ -Z direction to Γ -Y direction, which implies the addition of impurity has effect on not only the conduction band, but also the valance band dispersion.

Fig. 3. presents the energy band gap as a function of Al and In-contents for β -(Al_xIn_yGa_{1-x-y})₂O₃ alloys with x up to 12.5% and y up to 18.75%. The solid line and dotted line in Fig. 3. represent direct and indirect energy band gap property of the oxide alloys respectively. As shown in Fig. 3., the β -(Al_xIn_yGa_{1-x-y})₂O₃ alloys exhibit indirect bandgap property, which is consistent with the property of β -Ga₂O₃. As shown by the solid lines, the direct bandgap increases from 4.835eV to 5.086eV when the Al-content increases from 0% to 12.5% in β -(Al_xGa_{1-x})₂O₃, while it decreases from 4.835eV to 4.432eV in the β -(In_xGa_{1-x})₂O₃ alloys. This can be explained by the band property of Al_2O_3 and In_2O_3 , which possess bandgaps of ~7.5 eV and ~3 eV [8,9], respectively. The incorporation of aluminium content tends to enlarge the bandgap and the indium contrarily promotes bandgap to shrink. In addition, our analysis found that the quaternary alloy system can be designed to be lattice-matching with β -Ga₂O₃ alloy, implying the possibility of adjusting the band properties of β-Ga₂O₃-based material without creating compressive or tensile strain within the material systems.

Our analysis shows that there is a possibility to have a direct-indirect band gap property switching by introducing



Fig. 3 Energy bandgap of $-(Al_x In_y Ga_{1\times y})_2O_3$ alloy with Alcontent up to 12.5% and In-content up to 18.75%.

additional Indium or aluminium content in the β -Ga₂O₃-based materials. As shown in figure 3, there is an overlapping of the solid and break lines for Al-6.25% and Al-12.5% β -(Al_xIn_yGa_{1-x-y})₂O₃ alloys, indicating the tendency of bandgap type transferring from indirect to direct in the quaternary alloy. The difference between the direct and indirect bandgap for these alloys reduces from 0.0277 eV(β -(In_{0.0625}Ga_{0.9375})₂O₃ to 0.0016 eV (β -(Al_{x0.125}In_{0.1875}Ga_{0.6875})₂O₃), which is small.

The ultrawide bandgap gallium oxide-based material is expected to be applicable in the ultraviolet (UV) photodetector devices. The transition wavelength of β -(Al_xIn_yGa_{1-x-y})₂O₃ alloys covers a range of 240 nm to 280 nm, which implies that the β -(Al_xIn_yGa_{1-x-y})₂O₃ alloys can be applied for device applications operating in the deep UV regime.

C. Conclusions

In summary, First-Principle DFT calculations are carried out using GGA-PBE exchange correlation functional to investigate the electronic properties of β-(Al_xIn_yGa_{1-x-y})₂O₃ alloys. With Al-content and In-content changing from 0%~12.5% and 0%~18.75% respectively, the band structures of β -(Al_xIn_yGa_{1-x-y})₂O₃ alloys are found to exhibit indirect bandgap property with the bandgap energy ranging from 5.086 eV to 4.432 eV. Higher Al-content promotes the bandgap transferring from indirect to direct. The electronic properties of β -(Al_xIn_yGa_{1-x-y})₂O₃ alloys has yet been studied, and the relationship between the Al/In content and the bandgap of the quaternary alloy is presented for the first time. Our results are essential for device modeling and simulations involving the oxide materials. The wavelength corresponding to the bandgap energy is extracted which covers a region of 240~280nm, indicating the potential use of β -(Al_xIn_yGa_{1-x}- $_{\rm V})_2O_3$ alloys for deep UV photodetector.

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